

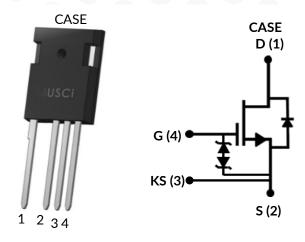


1200V-35m Ω SiC Cascode

Rev. A, January 2019

DATASHEET

UF3C120040K4S



Part Number	Package	Marking
UF3C120040K4S	TO-247-4L	UF3C120040K4S



Description

United Silicon Carbide's cascode products co-package its highperformance F3 SiC fast JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits very fast switching using a 4-terminal TO-247package and the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive.

Features

- Typical on-resistance R_{DS(on),typ} of 35mΩ
- Maximum operating temperature of 175°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- TO-247-4L package for faster switching, clean gate waveforms

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		1200	V
Gate-source voltage	V _{GS}	DC	-25 to +25	V
Continuous drain current ¹		T _C = 25°C	65	А
	ID	T _C = 100°C	47	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	175	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =4.2A	132.3	mJ
Power dissipation	P _{tot}	T _C = 25°C	429	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by $T_{J,max}$

2. Pulse width t_p limited by $T_{J,max}$

3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions		Units		
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.27	0.35	°C/W









Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Symbol	Test Conditions	Value			11	
Parameter			Min	Тур	Max	- Units	
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	1200			V	
Total drain leakage current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V, T _J =25°C		8	150		
		V _{DS} =1200V, V _{GS} =0V, T _J =175°C		35		μΑ	
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	±20	μA	
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =40A, T _J =25°C		35	45	mΩ	
		V _{GS} =12V, I _D =40A, T _J =175°C		73		11122	
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	4	5	6	V	
Gate resistance	R _G	f=1MHz, open drain		4.5		Ω	

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Linita
Parameter			Min	Тур	Max	- Units
Diode continuous forward current ¹	ا _s	T _C =25°C			65	A
Diode pulse current ²	I _{S,pulse}	T _C =25°C			175	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =20A, T _J =25°C		1.5	2	v
		V _{GS} =0V, I _F =20A, T _J =175°C		1.95		
Reverse recovery charge	Q _{rr}	V_{R} =800V, I _F =40A, V_{GS} =-5V, R _{G_EXT} =10Ω		358		nC
Reverse recovery time	t _{rr}	di/dt=2400A/µs, T _J =25°C		25		ns
Reverse recovery charge	Q _{rr}	V_{R} =800V, I _F =40A, V_{GS} =-5V, R _{G_EXT} =10Ω		259		nC
Reverse recovery time	t _{rr}	di/dt=2400A/μs, Τ _J =150°C		22		ns







Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			L Instead
			Min	Тур	Max	- Units
Input capacitance	C _{iss}	V _{DS} =100V, V _{GS} =0V		1500		
Output capacitance	C _{oss}	$v_{DS} = 100 v, v_{GS} = 0 v$ f=100kHz		210		pF
Reverse transfer capacitance	C _{rss}			1.7		
Effective output capacitance, energy related	C _{oss(er)}	V _{DS} =0V to 800V, V _{GS} =0V		112		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{DS} =0V to 800V, V _{GS} =0V		280		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =800V, V _{GS} =0V		35.6		μJ
Total gate charge	Q _G	– V _{DS} =800V, I _D =40A,		43		nC
Gate-drain charge	Q_{GD}	$V_{DS} = -5V \text{ to } 12V$		11		
Gate-source charge	Q_{GS}	VGS 5V to 12V		19		
Turn-on delay time	t _{d(on)}	V _{DS} =800V, I _D =40A,		24		- ns
Rise time	t _r	Gate Driver =-5V to +12V, Turn-on $R_{G,EXT}$ =8.5 Ω ,		27		
Turn-off delay time	t _{d(off)}			50		
Fall time	t _f	Turn-off $R_{G,EXT}$ =20 Ω		10		
Turn-on energy	E _{ON}	Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 10\Omega,$		780		μ
Turn-off energy	E _{OFF}			195		
Total switching energy	E _{TOTAL}	T _J =25°C		975		
Turn-on delay time	t _{d(on)}	V _{DS} =800V, I _D =40A,		23		
Rise time	t _r	Gate Driver =-5V to +12V, Turn-on $R_{G,EXT}$ =8.5 Ω , Turn-off $R_{G,EXT}$ =20 Ω		24		- ns
Turn-off delay time	t _{d(off)}			50		
Fall time	t _f			9		
Turn-on energy	E _{ON}	Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 10\Omega,$ $T_J=150^{\circ}C$		668		-
Turn-off energy	E _{OFF}			134		μJ
Total switching energy	E _{TOTAL}			802		1





Typical Performance Diagrams

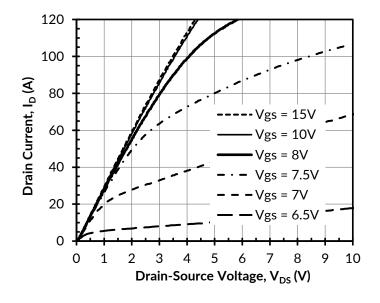


Figure 1. Typical output characteristics at $T_{\rm J}$ = - 55°C, tp < 250 μs

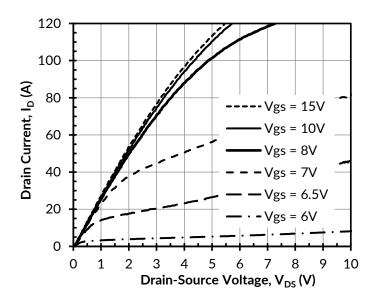


Figure 2. Typical output characteristics at $T_J = 25^{\circ}C$, tp < 250μ s

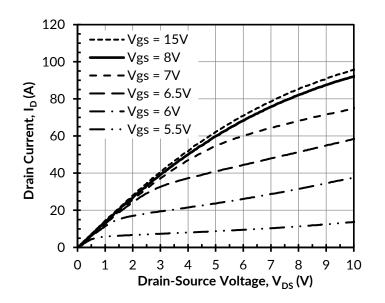


Figure 3. Typical output characteristics at T_J = 175°C, tp < 250 μ s

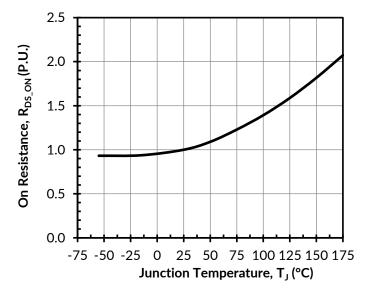


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 40A



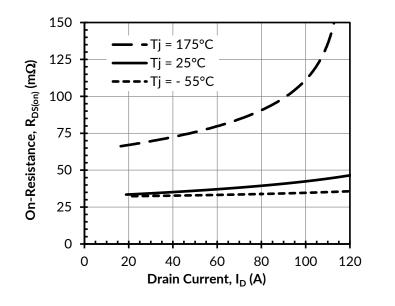
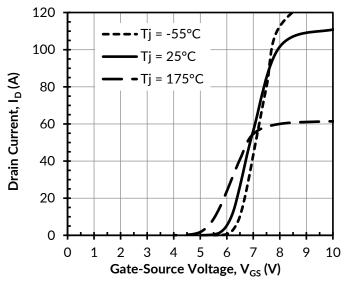


Figure 5. Typical drain-source on-resistances at V $_{\rm GS}$ = 12V



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Figure 6. Typical transfer characteristics at V_{DS} = 5V

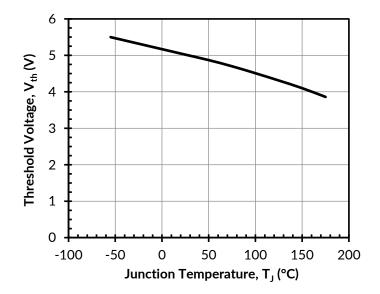


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

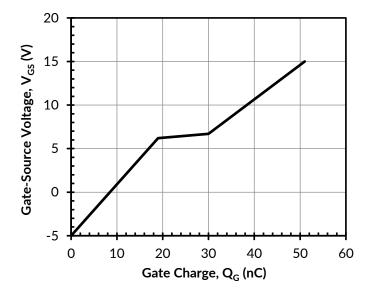


Figure 8. Typical gate charge at V_{DS} = 800V and I_{D} = 40A





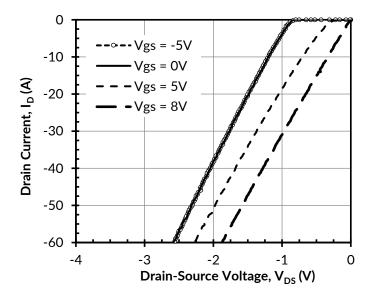


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

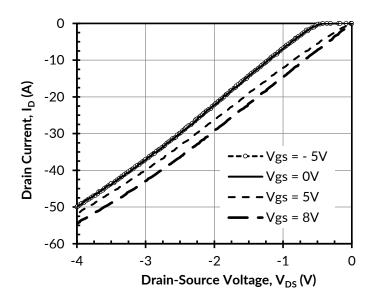


Figure 11. 3rd quadrant characteristics at T_J = 175°C

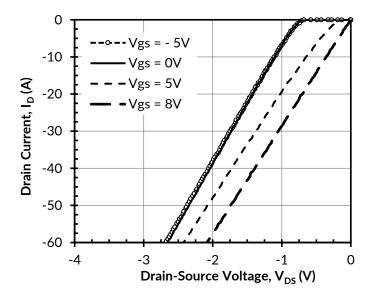


Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$

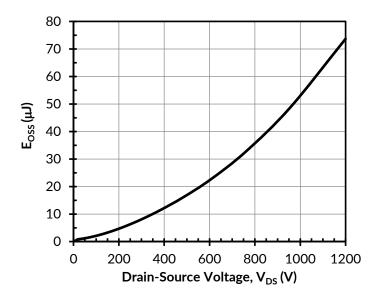


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V



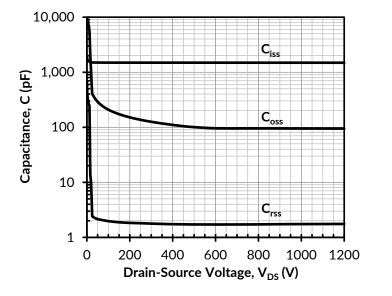
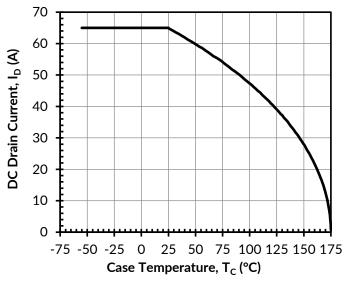


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V



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Figure 14. DC drain current derating

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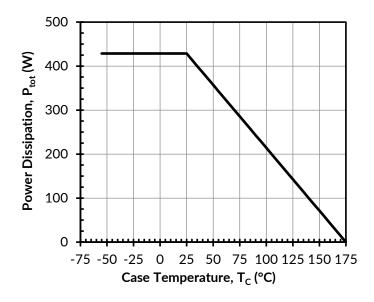


Figure 15. Total power dissipation

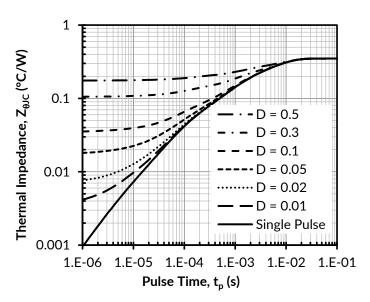


Figure 16. Maximum transient thermal impedance





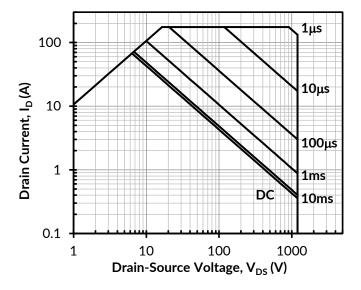


Figure 17. Safe operation area at T_{C} = 25°C, D = 0, Parameter $t_{\rm p}$

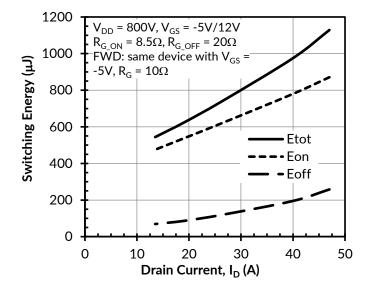


Figure 18. Clamped inductive switching energy vs. drain current at $T_J = 25^{\circ}C$

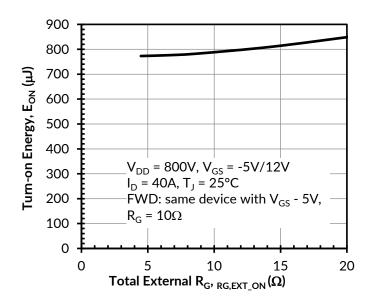


Figure 19. Clamped inductive switching turn-on energy vs. $R_{G,\text{EXT_ON}}$

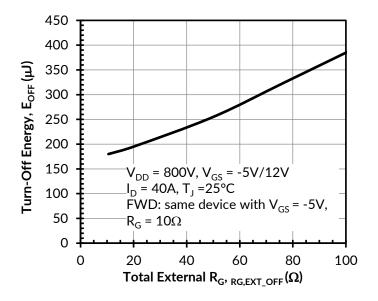


Figure 20. Clamped inductive switching turn-off energy vs. R_{G,EXT_OFF}



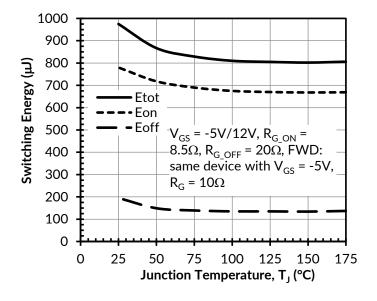
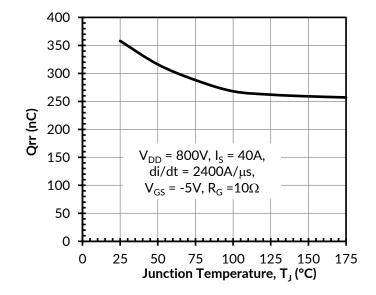


Figure 21. Clamped inductive switching energy vs. junction temperature at V_{DS} = 800V and I_D = 40A



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Figure 22. Reverse recovery charge Qrr vs. junction temperature

Applications Information

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see www.unitedsic.com.

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